# BARRY Design Parameters

For decades, Barry Industries has been working with engineers to create precise ceramic component solutions. We can build ceramic components from your existing drawing or design a new component to fit your exact specifications. Barry has the inhouse capabilities and experience to fulfill almost any ceramic requirement.

Vertical Integration is the key to our quality and success. Unsurpassed quality standards, precise attention to detail, excellent customer service and in-house control of our manufacturing process are some of the reasons to choose Barry as your ceramic component supplier.

#### **Design & Simulation Software:**

- Solidworks
- Sonnet EM

- ANSYS DesignSpace
- CST Microwave Studio







#### Ceramics:

Ceramics & Properties (Typical):	96% Alumina (Al <sub>2</sub> O <sub>3</sub> )	Aluminum Nitride (AIN)	Beryllium Oxide (BeO)
Thermal Conductivity @25°C (W/mK):	20 - 30	170 - 200	261
Dielectric Constant (at 1MHz):	9.5	8.6	6.5
CTE (PPM/° 25-150°C):	6.5	4.5	7.6

#### Ceramic Standard Thicknesses:

	0.010 [.254]	0.015 [.381]	0.025 [.635]	0.040 [1.016]	0.060 [1.524]◊		Min.	Max.			
96% Alumina (Al <sub>2</sub> O <sub>3</sub> )	٠	٠	٠	•		Α.	0.02 [0.508]	6.0 [152.4]	- 1		
Aluminum Nitride (AIN)	•	•	٠	•	٠	В.	0.02 [0.508]	6.0 [152.4]			
Bervllium Oxide (BeO										A	4

# Dimensions in inches [mm]. Tolerance is $\pm$ 0.010 [0.254] unless otherwise stated

Single Ceramic Piece Dimensions:

#### Conductors:

#### **Conductor & Via Guidelines:**

Parameter:	Min.	Standard 0
1. Conductor-to-Edge	.003 [0.0762]	.005 [0.1270]
2. Conductor Width	.002 [0.0508]	.005 [0.1270]
3. Conductor-to-Conductor Space	.002 [0.0508]	.008 [0.2032]
4. Conductor-to-Conductor Space (Dissimilar Metallizations)	.006 [0.1524]	.010 [0.2540]
5. Via Diameter to Ceramic Thickness Ratio	0.3:1	1.0:1
6. Pad-to-Edge Space	.003 [0.0762]	.005 [0.1270]
7. Pad Dimension	.008 [0.2032]	.010 [0.2540]
8. Pad-to-Pad Space	.008 [0.2032]	.010 [0.2540]



Conductor Edge Wrap Types:



Barry Industries maintains an ISO9001 Certified Quality Management System.

#### ♦ Greater Dimensions Available

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Barry Industries maintains an ISO9001 Certified Quality Management System.

#### **Resistive Element:**

#### **Resistor Element, Terminal & Passivation Guidelines:**

Parameter:	Min.	Standard
A. Resistor Length	.008 [0.2032]	.010 [0.2540]
B. Resistor Width	.008 [0.2032]	.010 [0.2540]
C. Resistor / Terminal Overlap	.003 [0.0762]	.005 [0.1270]
D. Terminal Extension (Lengthwise)	.003 [0.0762]	.010 [0.2540]
E. Terminal Extension (Widthwise)	.002 [0.0508]	.005 [0.1270]
F. Passivation Coverage (Lengthwise)	.003 [0.0762]	.005 [0.1270]
G. Passivation Coverage (Widthwise)	.003 [0.0762]	.005 [0.1270]
H. Resistor Edge to Nearby Conductor	.010 [0.2540]	.015 [0.3810]

#### **Resistor Electrical Parameters:**

Al <sub>2</sub> O <sub>3</sub> & BeO Value Range:	$0.1\Omega$ to $1G\Omega$
AIN Value Range:	$10\Omega$ to $1K\Omega$
Resistor Tolerance:	To $\pm 1\%$ (Value Dependant)
TCR:	200PPM/°C (Typical)

## Laser Trim Types:



В

'L' Cut • Improved RF Performance



Edge Trim · Improved Power & RF Performance

#### No Trim Option:



 Most Power Performance Poor Accuracy

Dimensions in inches [mm]. Tolerance is ± 0.010 [0.254] unless otherwise stated

### Flange & Leads:

#### Flange Metal Properties (Typical):

Material:	Thermal Conductivity @25°C (W/mK):	Density (g/cm <sup>3</sup> ):	CTE (PPM/° 25-150°C):	Bend Strength (MPa):	Young's Modulus (GPa):
Copper (Cu)	398	8.96	17.8	330	131
Copper Tungsten (CuW)	180 - 200	15.7 - 17	6.5 - 8.3	1172	367
Flange Guidelines:	:				

Parameter:	Min.◊
A. Flange Length (Single Screw Hole)	.200 [5.080]
B. Flange Width (Single Screw Hole)	.100 [2.540]
C. Diameter of Screw Hole	.100 [2.540]
D. Length of Lead	.050 [1.270]
E. Width of Lead	.020 [0.508]









◊ Greater Dimensions Available

**Customer Defined Testing:** 



1.

Vector Analyzer to 65GHz

Thermal Imaging





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**Optical CMM** 

**XRF** Imaging



Cycle Testing

> High Voltage Testing



Testing

Hi-Rel Life Testing

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